Bayesian Approach for Reliability Assessment of Sunshield Deployment on JWST

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Abstract—Deployable subsystems are essential to mission success of most spacecraft. These subsystems enable critical functions including power, communications and thermal control. The loss of any of these functions will generally result in loss of the mission. These subsystems and their components often consist of unique designs and applications, for which various standardized data sources are not applicable for estimating reliability and for assessing risks. In this study, a Bayesian approach for reliability estimation of spacecraft deployment was developed for this purpose. This approach was then applied to the James Webb Space Telescope (JWST) Sunshield subsystem, a unique design intended for thermal control of the observatory’s telescope and science instruments. In order to collect the prior information on deployable systems, detailed studies of “heritage information”, were conducted, extending over 45 years of spacecraft launches. The NASA Goddard Space Flight Center (GSFC) Spacecraft Operational Anomaly and Reporting System (SOARS) data were then used to estimate the parameters of the conjugate beta prior distribution for anomaly and failure occurrence, as the most consistent set of available data and that could be matched to launch histories. This allows for an empirical Bayesian prediction for the risk of an anomaly occurrence of the complex Sunshield deployment, with credibility limits, using prior deployment data and test information.

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1. Introduction

Deployable subsystems are essential to mission success of most spacecraft. These subsystems enable critical functions including power, communications and thermal control. The loss of any of these functions will generally result in loss or significant degradation of the mission [Freeman 1993, Saleh and Castell 2011, de Selding 2012]. These subsystems and their components often consist of unique designs and applications, for which various standardized data sources are not applicable for estimating reliability and for assessing risks.

From the reliability standpoint, deployable subsystems are best modeled as one-shot systems, for which probability of a failure/success event is governed by the binomial distribution. The mathematically correct classical (frequentist) maximum likelihood (ML) estimate of the probability of deployment failure \( p_f \) is the simple common sense estimate which is given by

\[
\hat{p}_f = \frac{n}{N}
\]

where \( N \) is the total number of trials (deployments), \( n \) is the number of unsuccessful trials, and \( \hat{p}_f \) is the estimate of the \( p_f \).

As a rule, one is interested in the upper \((1 - \alpha)\) confidence limit on the probability of deployment failure, which is given as a solution with respect to \( p \) of the following equation

\[
I_{1-\alpha}(N - n, n + 1) \leq \alpha
\]

where the incomplete beta function is given by [Lawless, 2003]
In the framework of the empirical Bayesian approach, the prior information might be a set of one-shot system failure/success data based on historical performance. Let's assume we have \( n_0 \) trials out of which \( x_0 \) are failures. In this case, the conjugate prior distribution is the beta distribution with parameters \( \alpha = x_0 \) and \( \beta = n_0 - x_0 \). At this point, it is important to note that the mean of the prior beta distribution \( p_{prior} \) is given by

\[
p_{prior} = \frac{x_0}{n_0}
\]

which coincides with classical estimate (1) of the probability of deployment failure. Thus, if there are available data on success/failure deployment related to some similar (from engineering standpoint) subsystems, these data can be used to estimate the parameters of the beta prior distribution. Note that in this case, the beta distribution parameters are integer. In the general case, e.g., when the prior distribution is estimated based on expert knowledge, the parameters can take on any positive values.

Next, let's assume that we have the test deployment results (data) related to the subsystem of interest, which are \( x \) failures out of \( n \) deployments (trials). Based on the Bayes' theorem, the posterior PDF of the probability of deployment failure can be written as

\[
f(p|x) = \frac{\Gamma(n+x_0)}{\Gamma(x+x_0)\Gamma(n+x_0-x-x_0)}p^{n+x_0-1}(1-p)^{x-x_0-1}
\]

which is obviously the PDF of the beta distribution.

The corresponding posterior mean (which is the Bayesian point estimate of the failure probability) is given by

\[
p_B = \frac{x+x_0}{n+n_0}
\]

It should be noted that when \( n >> n_0 \) and \( x >> x_0 \), the Bayesian estimate (8) is getting closer to the classical estimate (1) based on the test data. In other words, the classical statistical inference tends to dominate over the Bayesian one. Likewise, if \( n_0 >> n \) and \( x_0 >> x \), the Bayesian inference tends to dominate.

Based on the posterior PDF (7), the \((1-\alpha)\) upper limit \( p_{up} \) of Bayes' probability interval (the Bayesian analog of the classical upper confidence limit) is a solution of the following equation with respect to \( p \)

\[
f_p(x+x_0, n+n_0 - x - x_0) = \alpha
\]

Consider the following numerical example. Let the collected prior information be summarized as 100 deployments with, say, 2 failures, i.e., \( n_0 = 100 \) and \( x_0 = 2 \). The test data for a given deployable subsystem is limited to 10 failure-free deployments i.e., \( n = 10 \) and \( x = 0 \).

In this case, based on the test data classical point estimate (1) of probability of deployment failure is 0, which is not
very informative. The classical upper 90% confidence limit on the failure probability calculated using Equation (2) is 0.206.

Based on the prior and test data, the respective Bayesian upper 90% limit is 0.035, which looks consistent with the data it is based on.

3. Prior Data Sources for Deployable Subsystems Reliability Estimation

In analyzing deployments, several sources of information may be used for the construction of a prior distribution. In this study, sources of data analyzed, included the NASA Glenn Research Center’s (GRC) Spacecraft Mechanism Handbook [Fusaro, 1998] and the GSFC SOARS. SOARS is a demonstrated consistent source of historical data for NASA GSFC projects [Robertson and Stoneking 2003]. This provided a look at 45 years of deployment history. The total number of failures reviewed included 53 known failures. Figures 2 and 3 show a classification of all 53 failures by subsystems and assignable causes. Failures on the same spacecraft, appearing in both data sets, are treated as only one failure.

![Figure 2. Classification of Failures by Deployed Component Type.](image)

![Figure 3. Classification of Failures by Assignable Causes.](image)

Studies to support documentation of lessons learned for the Spacecraft Mechanism Handbook reflect failures occurring on military and civil spacecraft launched between 1964 and 1997. These data showed 34 failures. The exact population of spacecraft is not known for these data. However, there were approximately 1262 civil and military missions launched by the United States in this period. With a few exceptions, the data reflect largely mission ending failures, which were not overcome by operational workarounds and may not represent a complete anomaly record. The failure records can be examined in [Fusaro, 1998].

The SOARS records reflect NASA GSFC civil spacecraft developed and launched from 1978 to 2009. The data reflected 19 failures including both mission ending and failures which were overcome by operational workarounds. During this period, 123 spacecraft were successfully launched into orbit by NASA GSFC. This provides the most consistent data set for the construction of a prior distribution. Note that data were not segregated by severity for this example. This is of course an option in applying this methodology to test design.

4. Case Study — JWST Sunshield Deployment

The James Webb Space Telescope is the next generation space telescope, which will view deep space in the infrared, beginning with its launch in 2018. JWST will be one of the most complex deployable structures ever launched and will enable NASA to peer to the epoch of the formation of the very first luminous objects after the primordial Big Bang. The JWST is shown in Figure 4, as it will be deployed in the Sun-Earth L2 orbit, in which it will conduct its mission.

4.1 The JWST Sunshield and its Deployment

Central to the success of the mission is the sunshield structure, a tennis court size, multi-layer, gossamer film structure, which enables the telescope and science instruments to cool to cryogenic temperatures, while blocking light from the sun.

![Figure 4. The James Webb Space Telescope in its Deployed Configuration Showing the Optical Telescope Element and Sunshield.](image)
The SOARS records from 1978 through 2009 were analyzed to generate a prior distribution for this analysis. Out of these records, 123 missions were selected as having the deployable subsystems, which can be used as the prior data for the JWST sunshield Bayesian reliability analysis. In 19 of these missions, deployable subsystem anomalies occurred, ending the mission, degrading the mission or creating an operational contingency.

In this case study, we are considering application of the Bayesian approach to test design. Let’s assume that a test sequence of 10 deployments has been run and the test results are failure free. Based on the prior data, the prior PDF is depicted in Figure 6.

The prior mean coinciding with the classical maximum likelihood (ML) estimate (1) is $\frac{19}{123} = 0.154$. Using Equation (8), the Bayesian point estimate is evaluated as

$$p_B = \frac{19}{123 + 10} = 0.143$$

(10)

Based on the prior and test data, the respective Bayesian upper 90% limit is 0.182. Clearly, the minimum test sequences to run for the system can be targeted based upon the desired risk reduction using this approach.

Now, we assume that the test result is one failure out of 10 deployment sequences. In this case, the Bayesian point estimate is 0.154 and the Bayesian upper 90% limit is 0.191. If our analysis was limited to the classical approach, we could only compare the 90% upper confidence limit on failure probability for 0 out of 10 test result with the test having one failure out of 10, which are 0.205 and 0.337 respectively. We can see that using the prior data in the Bayesian approach for reliability estimation is rather robust with respect to the test results. It can be explained by the dominance of the prior information over the test data, which is, to an extent, typical for the deployable systems of interest.

It should be noted that the Bayesian estimate of probability of deployment failure can be updated not only as a result of additional test runs, but also through updating the prior information, as soon as new empirical data become available.

5. CONCLUSION

In this paper we have presented an empirical Bayesian approach to analysis of deployment risk and reliability. The deployable system is modeled as a one-shot system governed by the binomial distribution. This allowed for the use of conjugate beta distributions to explicitly treat the uncertainties in the probability of success. The application is demonstrated by an example test case using 10 deployment sequences for a deployable system. This methodology can also be used to establish test cycles needed to achieve a particular risk or reliability target. The methodology uses data explicitly. However, the historical or other prior data can be expected to dominate the results of the posterior estimates.

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Biographies

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